## Notice of References Cited Application/Control No. 10/585,531 Examiner NATHAN H. EMPIE Applicant(s)/Patent Under Reexamination NGUYEN ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,299,734	11-1981	Fujitani et al.	502/304
*	В	US-5,217,938	06-1993	Reinalda et al.	502/325
*	С	US-5,437,832	08-1995	Imamura et al.	419/2
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
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	-	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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